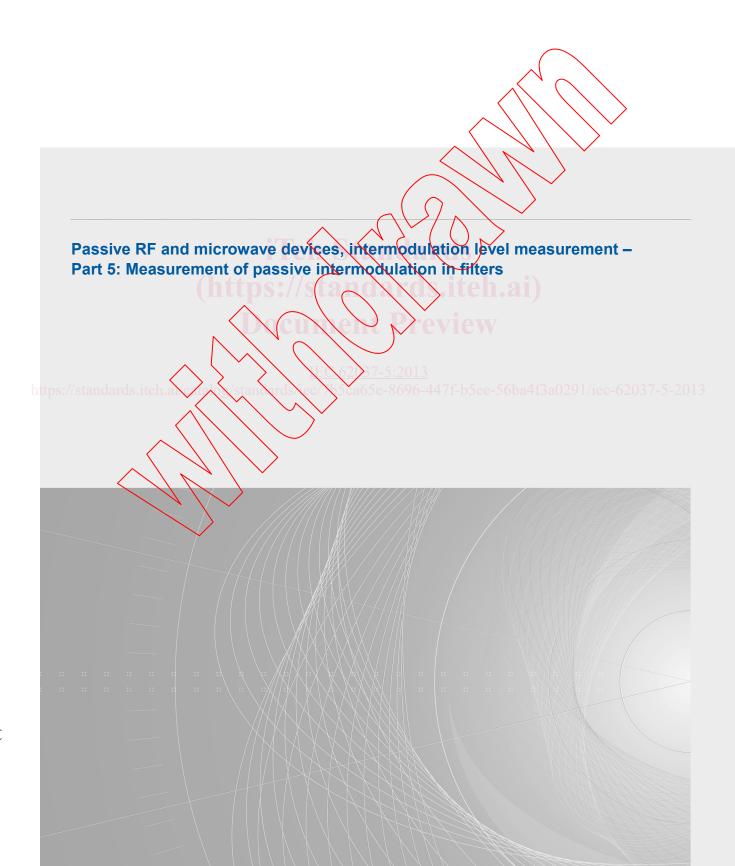


Edition 1.0 2013-01

INTERNATIONAL STANDARD





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INTERNATIONAL STANDARD

Passive RF and microwave devices, intermodulation level measurement – Part 5: Measurement of passive intermodulation in filters



INTERNATIONAL ELECTROTECHNICAL COMMISSION

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

PASSIVE RF AND MICROWAVE DEVICES, INTERMODULATION LEVEL MEASUREMENT –

Part 5: Measurement of passive intermodulation in filters

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